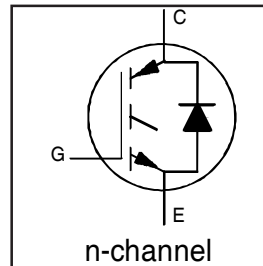


IRG4PH40UD2-E

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE UltraFast CoPack IGBT

Features

- UltraFast IGBT optimized for high operating frequencies up to 200kHz in resonant mode
- IGBT co-packaged with HEXFRED™ ultrafast ultra-soft-recovery anti-parallel diode for use in resonant circuits
- Industry standard TO-247AD package with extended leads



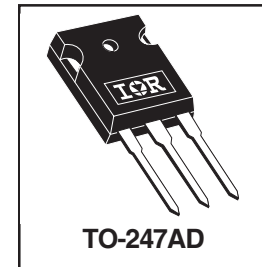
| |
|-----------------------------|
| $V_{CES} = 1200V$ |
| $V_{CE(on) typ.} = 2.43V$ |
| @ $V_{GE} = 15V, I_C = 21A$ |

Benefits

- Higher switching frequency capability than competitive IGBTs
- Highest efficiency available
- HEXFRED diodes optimized for performance with IGBTs. Minimized recovery characteristics require less / no snubbing

Applications

- Induction cooking systems
- Microwave Ovens
- Resonant Circuits



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|-----------------------------------|-------|
| V_{CES} | Collector-to-Emitter Voltage | 1200 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 41 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 21 | |
| I_{CM} | Pulse Collector Current ① | 82 | |
| I_{LM} | Clamped Inductive Load current ② | 82 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 10 | |
| I_{FM} | Diode Maximum Forward Current | 40 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 160 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 65 | |
| T_J | Operating Junction and Storage Temperature Range | -55 to +150 | °C |
| T_{STG} | | | |
| | Soldering Temperature, for 10 sec. | 300 (0.063 in. (1.6mm) from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1N•m) | |

Thermal / Mechanical Characteristics

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|---|------|----------|------|---------|
| $R_{\theta JC}$ | Junction-to-Case- IGBT | — | — | 0.77 | °C/W |
| $R_{\theta JC}$ | Junction-to-Case- Diode | — | — | 2.5 | |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface | — | 0.24 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | — | — | 40 | |
| Wt | Weight | — | 6 (0.21) | — | g (oz.) |

IRG4PH40UD2-E

International
IRF Rectifier

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| Parameter | Min. | Typ. | Max. | Units | Conditions | |
|--|---|------|------|-------|--|--|
| V _{(BR)CES} | 1200 | — | — | V | V _{GE} = 0V, I _C = 250μA | |
| V _{(BR)ECS} | 18 | — | — | V | V _{GE} = 0V, I _C = 1.0A | |
| ΔV _{(BR)CES} /ΔT _J | — | 0.43 | — | V/°C | V _{GE} = 0V, I _C = 1mA | |
| V _{CE(on)} | Collector-to-Emitter Saturation Voltage | — | 2.43 | 3.1 | V | I _C = 21A, V _{GE} = 15V See Fig.2, 5 |
| | | — | 2.97 | — | | |
| | | — | 2.47 | — | | |
| V _{GE(th)} | 3.0 | — | 6.0 | | V _{CE} = V _{GE} , I _C = 250μA | |
| ΔV _{GE(th)} /ΔT _J | — | -11 | — | mV/°C | V _{CE} = V _{GE} , I _C = 250μA | |
| g _f | 16 | 24 | — | S | V _{CE} = 100V, I _C = 21A | |
| I _{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | V _{GE} = 0V, V _{CE} = 1200V V _{GE} = 0V, V _{CE} = 1200V, T _J = 150°C |
| | | — | — | 5000 | | |
| V _{FM} | Diode Forward Voltage Drop | — | 3.4 | 3.8 | V | I _F = 10A, See Fig.13 I _F = 10A, T _J = 150°C |
| | | — | 3.3 | 3.7 | | |
| I _{GES} | Gate-to-Emitter Leakage Current | — | — | ±100 | nA | V _{GE} = ±20V |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| Parameter | Min. | Typ. | Max. | Units | Conditions | |
|-------------------------|---|------|------|-------|---|--|
| Q _g | — | 100 | 150 | nC | I _C = 21A V _{CC} = 400V, See Fig.8 V _{GE} = 15V | |
| Q _{ge} | — | 18 | 24 | | | |
| Q _{gc} | — | 34 | 50 | | | |
| t _{d(on)} | — | 22 | — | ns | I _C = 21A, V _{CC} = 800V V _{GE} = 15V, R _G = 10Ω Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18 | |
| t _r | — | 26 | — | | | |
| t _{d(off)} | — | 100 | 140 | | | |
| t _f | — | 200 | 300 | | | |
| E _{on} | — | 1950 | — | μJ | T _J = 150°C, See Fig. 9, 10, 11, 18 I _C = 21A, V _{CC} = 800V V _{GE} = 15V, R _G = 10Ω Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18 | |
| E _{off} | — | 1710 | — | | | |
| E _{tot} | — | 3660 | 4490 | | | |
| t _{d(on)} | — | 21 | — | ns | T _J = 150°C, See Fig. 9, 10, 11, 18 I _C = 21A, V _{CC} = 800V V _{GE} = 15V, R _G = 10Ω Energy losses include "tail" and diode reverse recovery. | |
| t _r | — | 25 | — | | | |
| t _{d(off)} | — | 220 | — | | | |
| t _f | — | 380 | — | | | |
| E _{TS} | — | 6220 | — | μJ | Measured 5mm from package | |
| L _E | — | 13 | — | nH | | |
| C _{ies} | — | 2100 | — | pF | V _{GE} = 0V V _{CC} = 30V, See Fig.7 f = 1.0MHz | |
| C _{oes} | — | 99 | — | | | |
| C _{res} | — | 12 | — | | | |
| t _{rr} | Diode Reverse Recovery Time | — | 50 | 76 | ns | T _J =25°C, See Fig. 14 T _J =125°C, 14 |
| | | — | 72 | 110 | | |
| I _{rr} | Diode Peak Reverse Recovery Current | — | 4.4 | 7.0 | A | T _J =25°C, See Fig. 15 T _J =125°C, 15 |
| | | — | 5.9 | 8.8 | | |
| Q _{rr} | Diode Reverse Recovery Charge | — | 130 | 200 | nC | T _J =25°C, See Fig. 16 T _J =125°C, 16 |
| | | — | 250 | 380 | | |
| di _(rec) /dt | Diode Peak Rate of Fall of Recovery During t _b | — | 210 | — | A/μs | T _J =25°C, See Fig. 17 T _J =125°C, 17 |
| | | — | 180 | — | | |

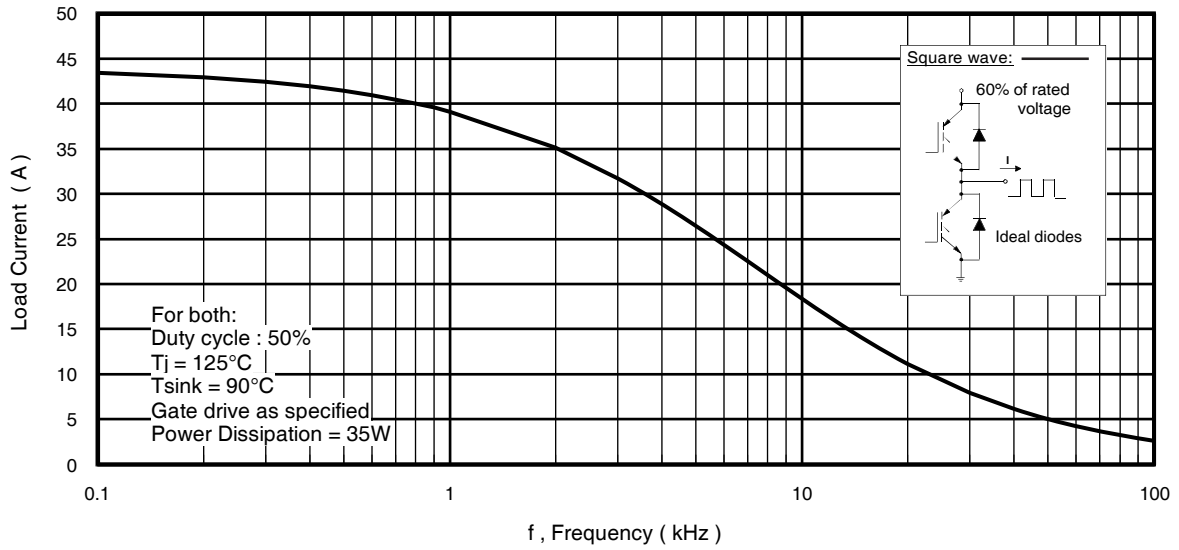


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

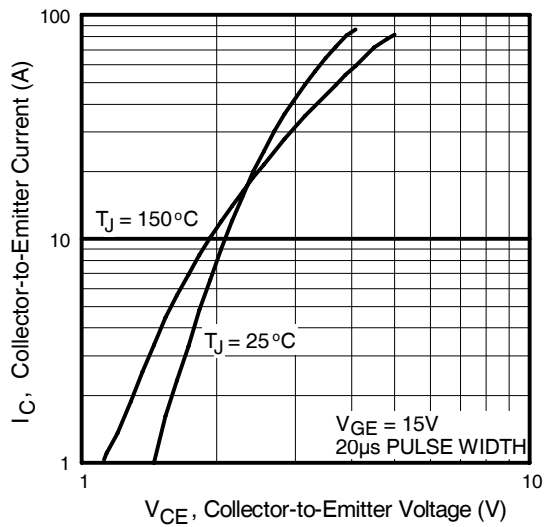


Fig. 2 - Typical Output Characteristics
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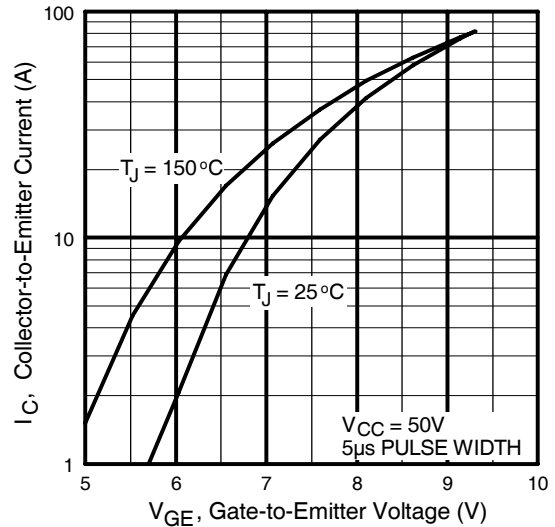


Fig. 3 - Typical Transfer Characteristics

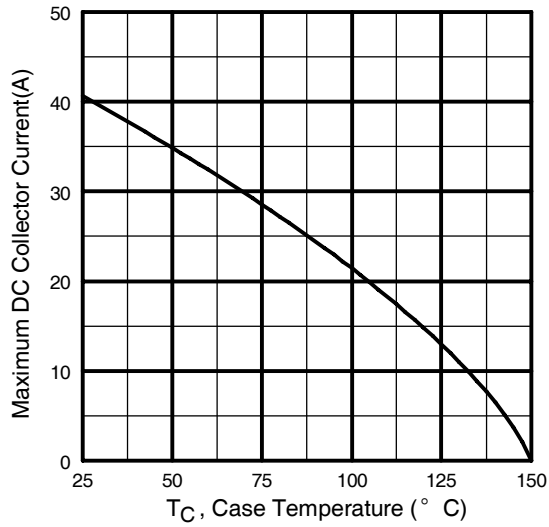


Fig. 4 - Maximum Collector Current vs. Case Temperature

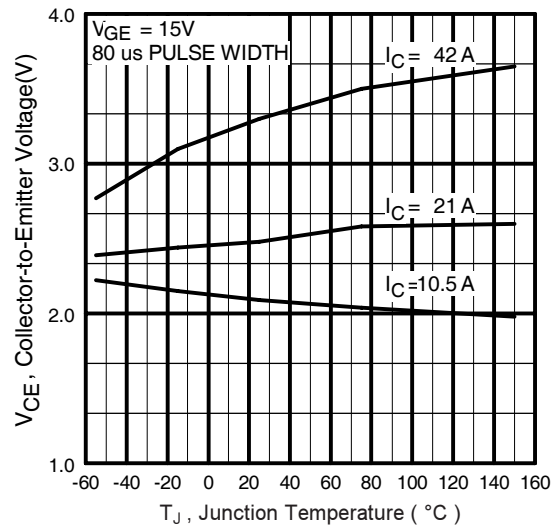


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

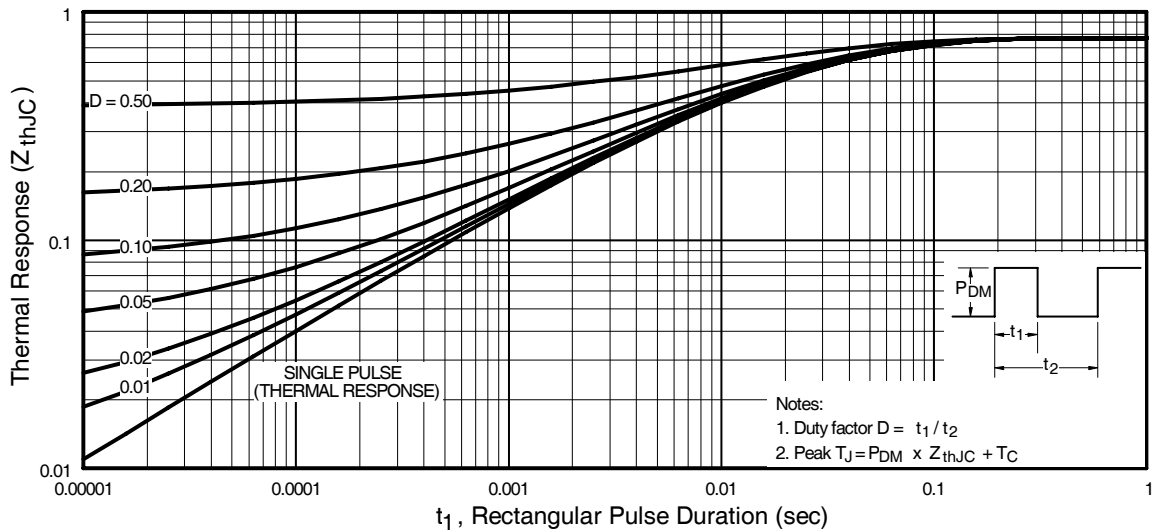


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

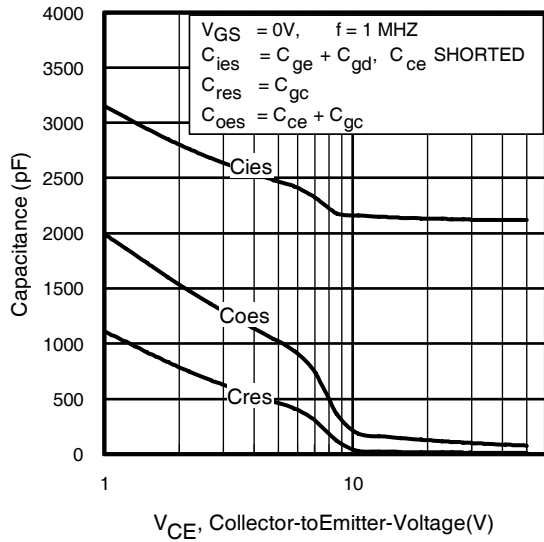


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

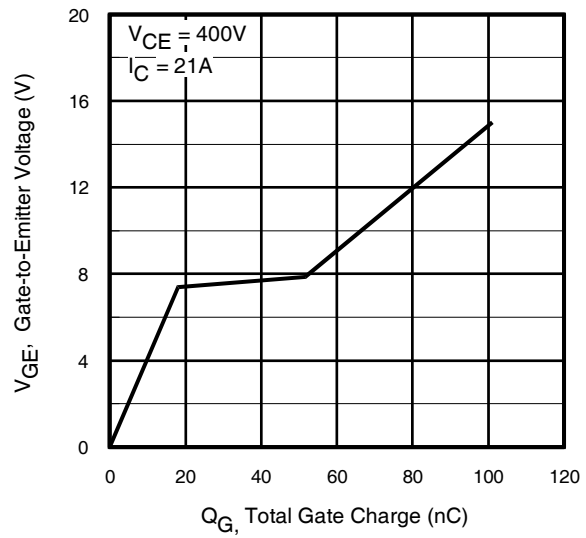


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

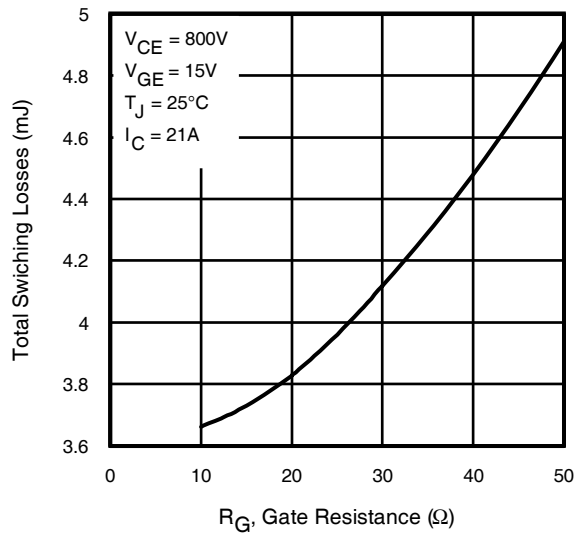


Fig. 9 - Typical Switching Losses vs. Gate Resistance

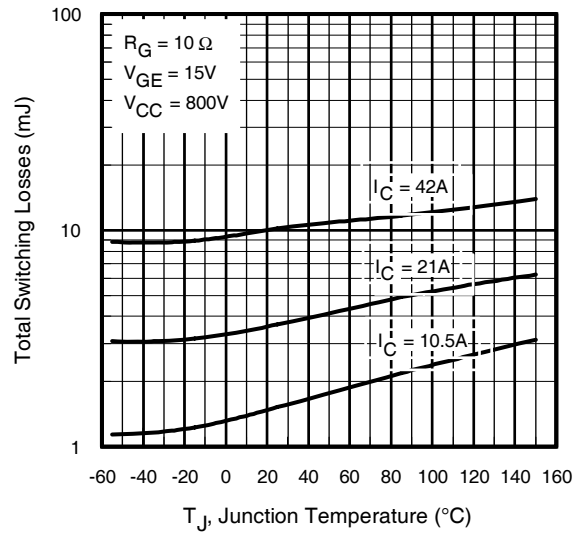


Fig. 10 - Typical Switching Losses vs. Junction Temperature

IRG4PH40UD2-E

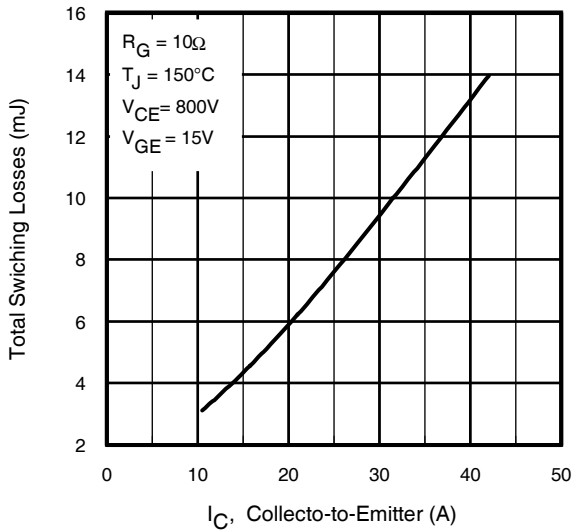


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

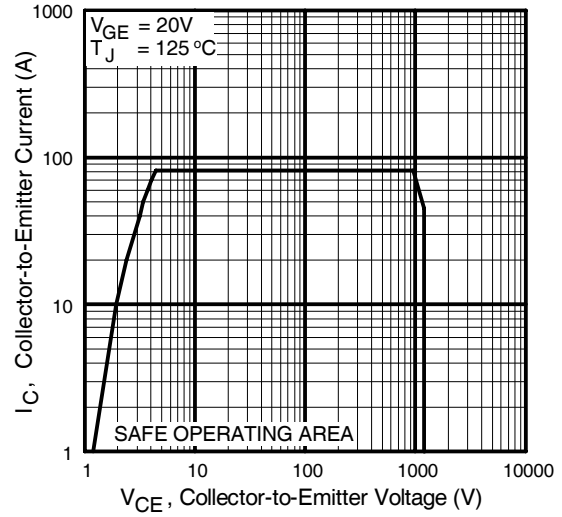


Fig. 12 - Turn-Off SOA

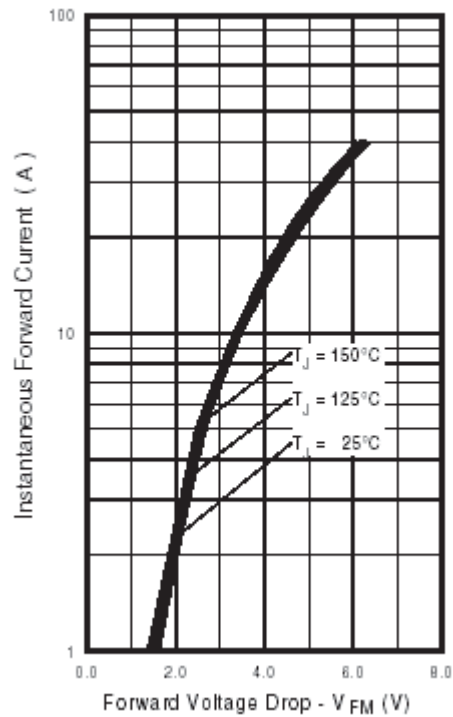


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

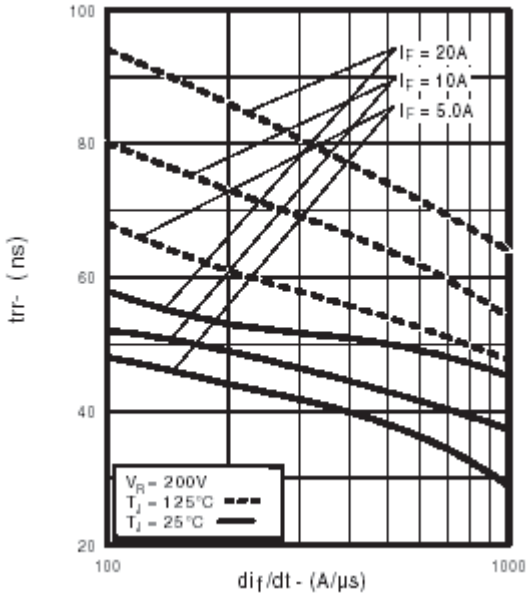


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

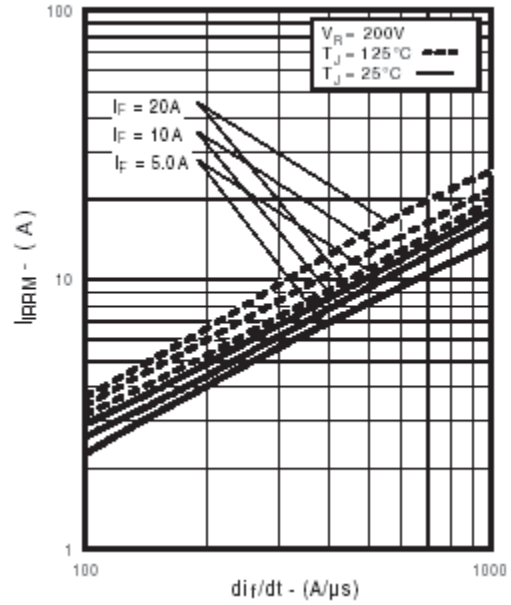


Fig. 15 - Typical Recovery Current vs. di_f/dt

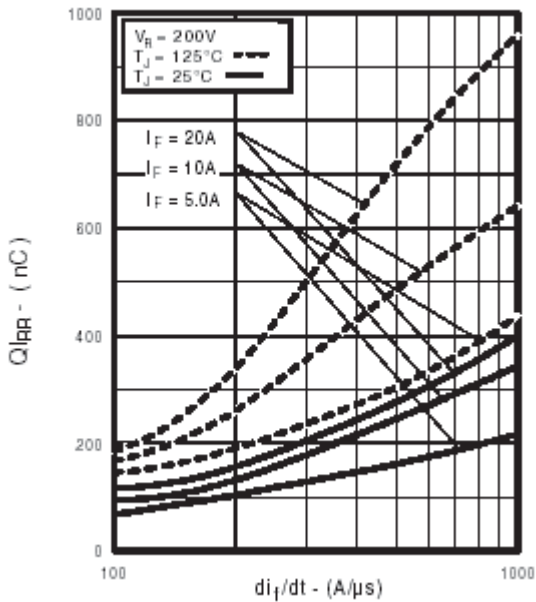


Fig. 16 - Typical Stored Charge vs. di_f/dt
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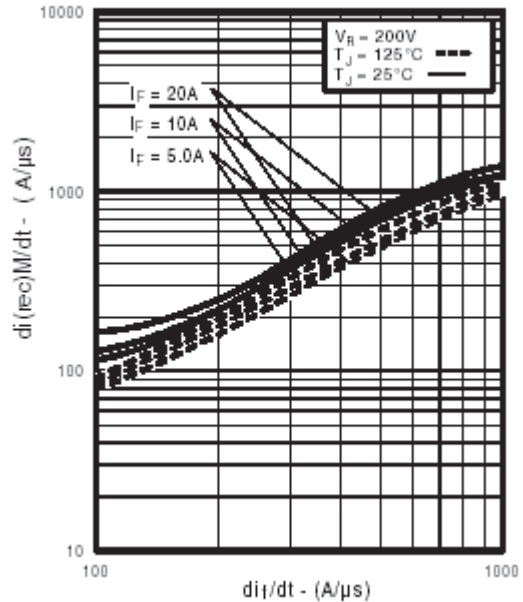


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

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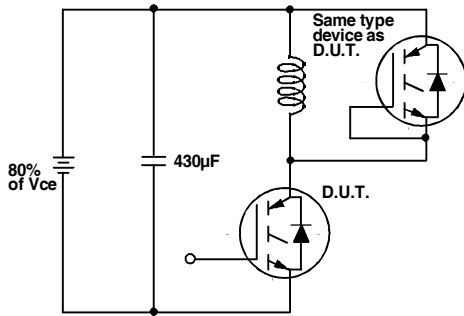


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

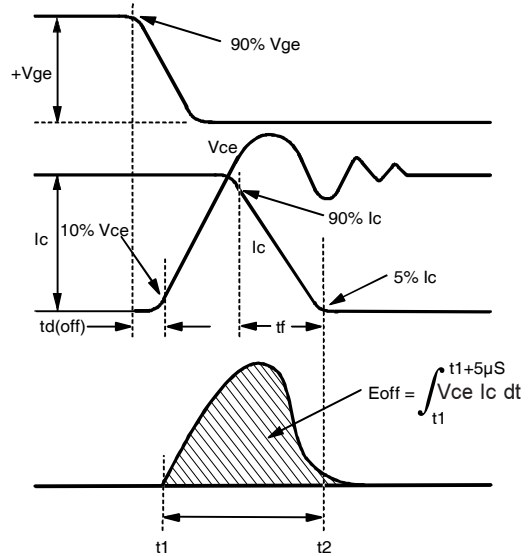


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

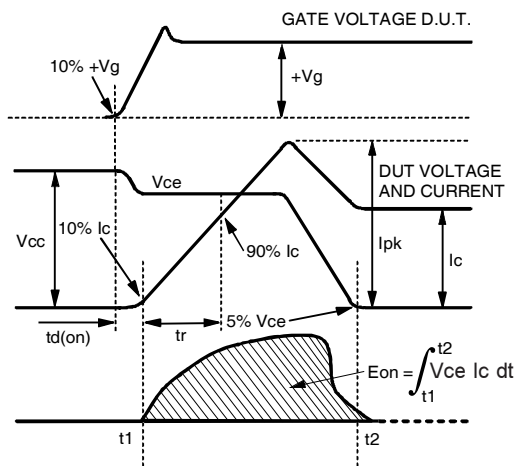


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

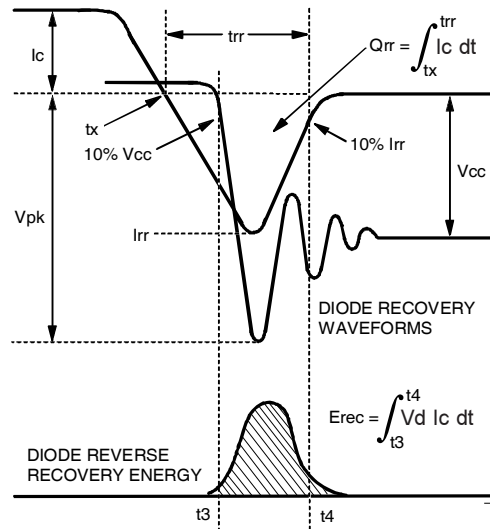


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

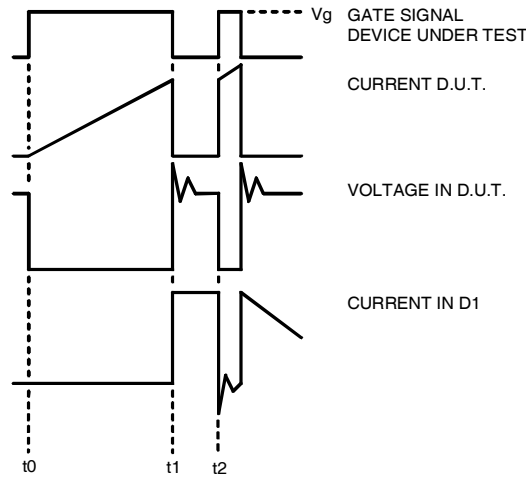


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

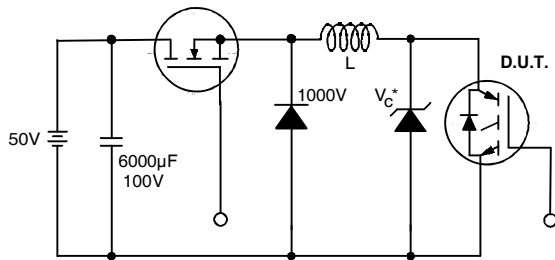


Figure 19. Clamped Inductive Load Test Circuit

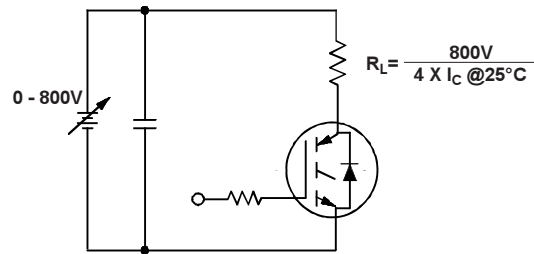


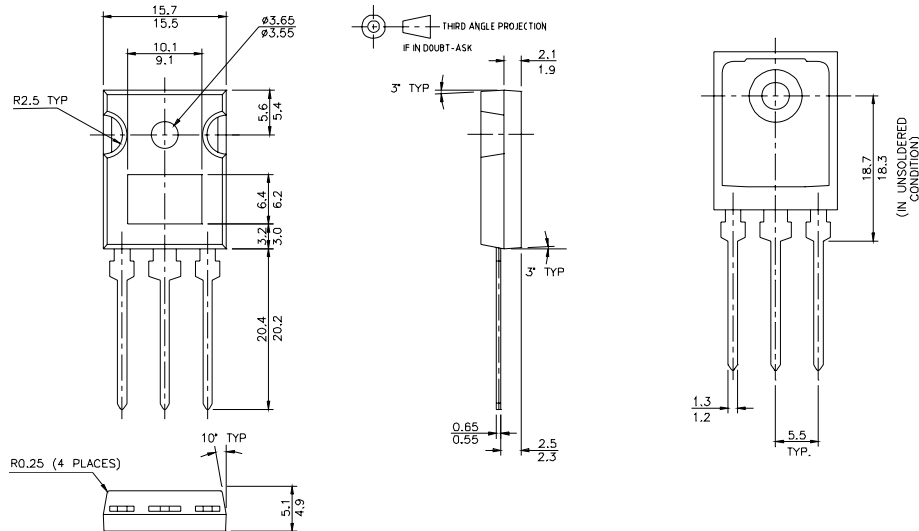
Figure 20. Pulsed Collector Current Test Circuit

IRG4PH40UD2-E

TO-247AD Package Outline

Dimensions are shown in millimeters (inches)

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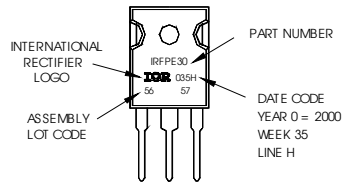


TO-247AD Part Marking Information

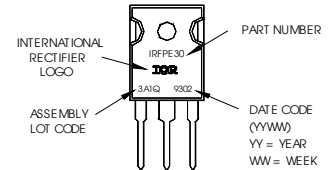
Notes: This part marking information applies to devices produced after 02/26/2001

Notes: This part marking information applies to devices produced before 02/26/2001 or for parts manufactured in GB.

EXAMPLE: THIS IS AN IRFPE30
WITH ASSEMBLY
LOT CODE 5667
ASSEMBLED ON WW35, 2000
IN THE ASSEMBLY LINE "H"



EXAMPLE: THIS IS AN IRFPE30
WITH ASSEMBLY
LOT CODE 3A1Q



Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G=10\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.

TO-247AD package is not recommended for Surface Mount Application.

Data and specifications subject to change without notice.
This product has been designed and qualified for Industrial market.
Qualification Standards can be found on IR's Web site.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information. 04/07
www.irf.com

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>